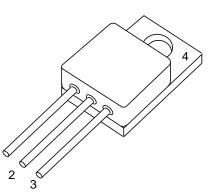


### Data Sheet BUY25CS12K-01

### HiRel RadHard Power-MOS

- Low R<sub>DS(on)</sub>
- Total Ionisation Dose (TID) hardened 100 kRad approved (Level R)
- Hermetically sealed
- N-channel



Туре	Marking	Pin Configuration				Package
		1	2	3	4	
BUY25CS12K-01	-	D	S	G	Not connected	TO-257AA
BUY25CS12K-11	-	G	D	S	Not connected	TO-257AA

#### **Maximum Ratings**

Parameter	Symbol	Values	Unit
Drain Source Voltage	V <sub>DS</sub>	250	V
Gate Source Voltage	V <sub>GS</sub>	+/- 20	V
Drain Gate Voltage	V <sub>DG</sub>	250	V
Continuous Drain Current $T_c = 25 \ ^{\circ}C$ $T_c = 100 \ ^{\circ}C$	I <sub>D</sub>	12.4 8	A
Continuous Source Current	Is	12.4	А
Drain Current Pulsed, $t_p$ limited by $T_{jmax}$	I <sub>DM</sub>	50	Apk
Total Power Dissipation 1)	P <sub>tot</sub>	75	W
Junction Temperature	TJ	-55 to + 150	°C
Operating and Storage Temperature	T <sub>op</sub>	-55 to + 150	°C
Avalanche Energy	E <sub>AS</sub>	60	mJ

#### **Thermal Characteristics**

Thermal Resistance (Junction to Case)	R <sub>th JC</sub>	1.66	K/W
Soldering Temperature	T <sub>sol</sub>	250	°C

#### Notes .:

1) For  $T_S \le 25^{\circ}$ C. For  $T_S > 25^{\circ}$ C derating is required.



#### Data Sheet BUY25CS12K-01

Electrical Characteristics, at T<sub>A</sub>=25°C; unless otherwise specified

Parameter	Symbol		Values	Unit	
		min.	typ.	max.	
DC Characteristics	·			·	
Breakdown Voltage Drain to Source $I_D = 0.25 \text{mA}, V_{GS} = 0 \text{V}$	B <sub>VDSS</sub>	250	-	-	V
Gate Threshold Voltage I <sub>D</sub> = 1.0mA, V <sub>DS</sub> ≥ V <sub>GS</sub>	$V_{GS(th)}$	2.0	-	4.0	V
Gate to Source Leakage Current V <sub>DS</sub> = 0V, V <sub>GS</sub> = +/- 20V	I <sub>GSS</sub>	-	-	+/-100	nA
Drain Current V <sub>DS</sub> = 200V, V <sub>GS</sub> = 0V	I <sub>DSS</sub>	-	-	25	μA
Drain Source On Resistance <sup>1)</sup> $V_{GS} = 10V, I_D = 8A$	r <sub>DS(ON)</sub>	-	-	0.13	Ω
Source Drain Diode, Forward Voltage <sup>1), 2)</sup> $V_{GS} = 0V$ , $I_S = 12.4A$	V <sub>SD</sub>	-	-	1.2	V
AC Characteristics					
Turn-on Delay Time V <sub>DD</sub> = 50% V <sub>DS</sub> , I <sub>D</sub> = 8A, R <sub>G</sub> = 4.7 $\Omega$	t <sub>d(ON)</sub>	-	14	25	ns
Rise Time $V_{DD}$ = 50% $V_{DS}$ , $I_D$ = 8A, $R_G$ = 4.7 $\Omega$	t <sub>r</sub>	-	7	25	ns
Turn-off Delay Time $V_{DD}$ = 50% $V_{DS}$ , $I_D$ = 8A, $R_G$ = 4.7 $\Omega$	$t_{d(OFF)}$	-	25	35	ns
Fall Time $V_{DD}$ = 50% $V_{DS}$ , $I_{D}$ = 8A, $R_{G}$ = 4.7 $\Omega$	t <sub>f</sub>	-	5	20	ns
Reverse Recovery Time V <sub>DD</sub> < 50% V <sub>DS</sub> , I <sub>D</sub> = 12.4A	t <sub>rr</sub>	-	300	400	ns
Common Source Input Capacitance $V_{DS} = 100V, V_{GS} = 0V, f = 1.0MHz$	C <sub>iss</sub>	1.3	-	1.9	nF
Common Source Output Capacitance $V_{DS} = 100V, V_{GS} = 0V, f = 1.0MHz$	C <sub>oss</sub>	90	-	150	pF
Common Source Reverse Transfer Capacitance V <sub>DS</sub> = 100V, V <sub>GS</sub> = 0V, f = 1.0MHz	C <sub>rss</sub>	1	-	6	pF
Total Gate Charge $V_{DD} = 50\% V_{DS}, V_{GS} = 10V, I_D = 12.4A$	Q <sub>G</sub>	-	25	42	nC

Notes.: 1) Pulsed Measurement: Pulse Width < 300µs, Duty Cycle <2.0%. 2) Measured within 2.0 mm of case.



### **Electrical Characteristics**

at T<sub>A</sub>=125°C; unless otherwise specified

Parameter	Symbol	Values		Unit	
		min.	max.		
DC Characteristics	·		ŀ		
Gate Threshold Voltage $I_D = 1.0 \text{mA}, V_{DS} \ge V_{GS}$	V <sub>GS(th)</sub>	1.5	-	V	
Gate to Source Leakage Current $V_{DS} = 0V, V_{GS} = +/-20V$	I <sub>GSS</sub>	-	+/-200	nA	
Drain Current $V_{DS} = 200V, V_{GS} = 0V$	I <sub>DSS</sub>	-	250	μA	
Drain Source On Resistance <sup>1)</sup> $V_{GS} = 10V, I_D = 8A$	r <sub>DS(ON)</sub>	-	0.3	Ω	

Notes.: 1) Pulsed Measurement: Pulse Width < 300µs, Duty Cycle <2.0%.

#### **Electrical Characteristics**

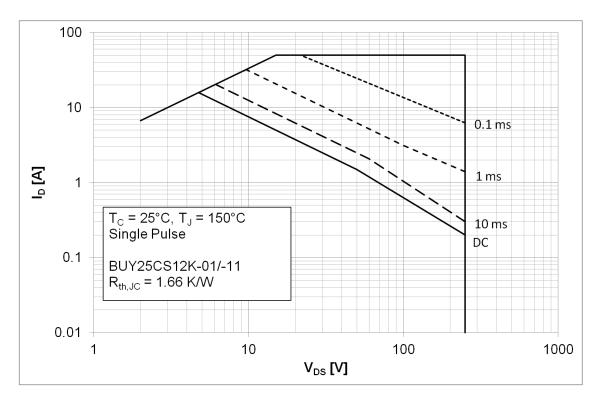
at T<sub>A</sub>=-55°C; unless otherwise specified

Parameter	Symbol	Values		Unit		
		min.	max.			
DC Characteristics						
Gate Threshold Voltage $I_D = 1.0mA, V_{DS} \ge V_{GS}$	V <sub>GS(th)</sub>	-	5.0	V		



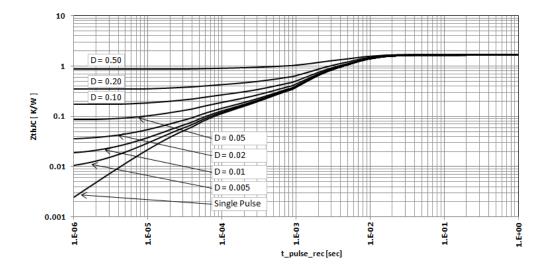
#### 1 Safe operating area

 $I_D = f(V_{DS}); T_C = 25^{\circ}C$ parameter:  $t_p$ 



#### 2 Max. transient thermal impedance

 $Z_{thJC} = f(t_p)$ parameter: D =  $t_p/T$ 



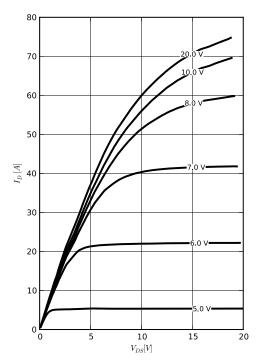


### Data Sheet

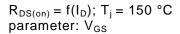
## BUY25CS12K-01

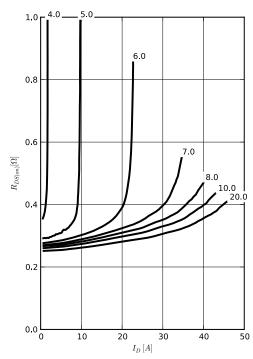
#### 3 Typ. output characteristics

 $I_D = f(V_{DS}); T_j = 25 \ ^{\circ}C$ parameter:  $V_{GS}$ 



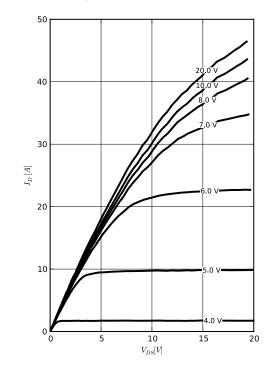
# 5 Typ. drain-source on-state resistance





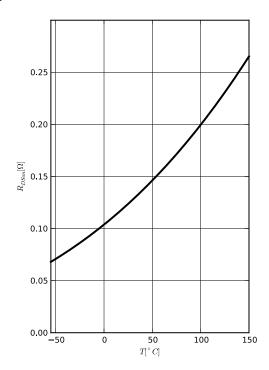
### 4 Typ. output characteristics

 $I_D = f(V_{DS}); T_j = 150 \ ^{\circ}C$ parameter:  $V_G$ 



6 Typ. drain-source on-state resistance

 $\begin{array}{l} \mathsf{R}_{\mathsf{DS}(\mathsf{on})} = \mathsf{f}(\mathsf{T}_j) \\ \mathsf{I}_\mathsf{D} = 8\mathsf{A} \end{array}$ 



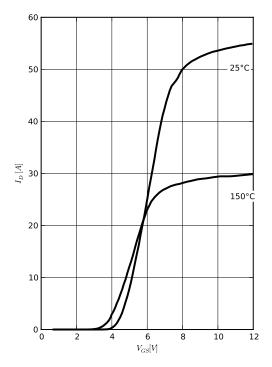


## Data Sheet

## BUY25CS12K-01

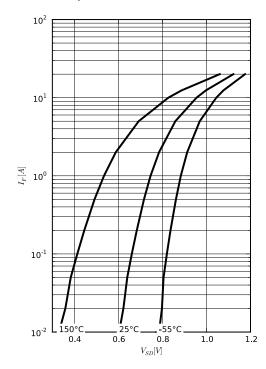
### 7 Typ. transfer characteristics

 $I_{D} = f(V_{GS}); |VDS| > 2 |I_{D}| R_{DS(on)max}$  parameter:  $T_{i}$ 



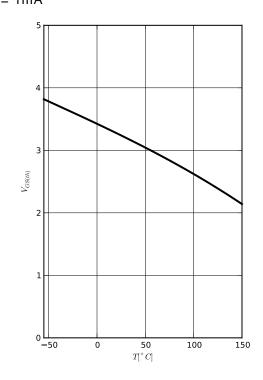
# 9 Typ. forward characteristics of reverse diode

 $I_F = f(V_{SD})$ parameter:  $T_i$ 



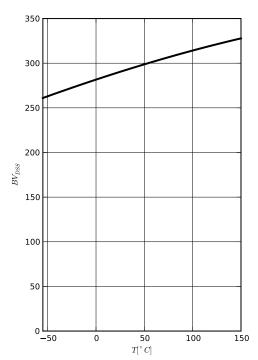
### 8 Typ. gate threshold voltage

$$I_D = f(T_j)$$
  
 $I_D = 1mA$ 



# 10 Typ. drain-source breakdown voltage

 $\begin{array}{l} \mathsf{BV}_{\mathsf{DSS}} = \mathsf{f}(\mathsf{T}_{\mathsf{j}}) \\ \mathsf{I}_{\mathsf{D}} = 250 \mu \mathsf{A} \end{array}$ 

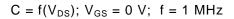


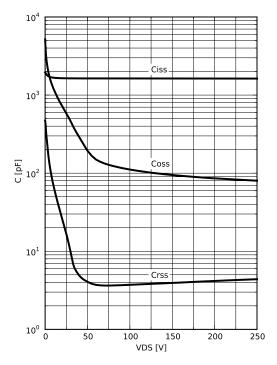


### Data Sheet

### BUY25CS12K-01 12 Typ. gate charge

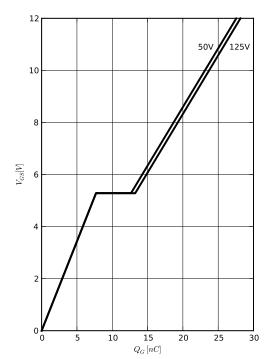
### 11 Typ. capacitances





### 12 Typ. gate charge

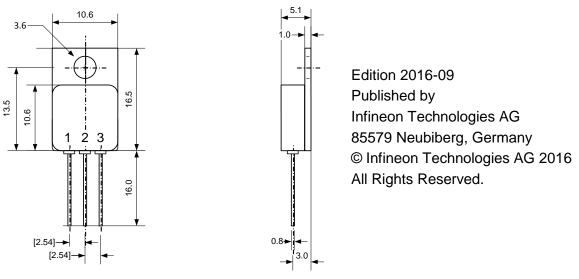
 $V_{GS} = f(Q_{gate}); ID = 12.4 A pulsed parameter: V_{DD}$ 





### Data Sheet BUY25CS12K-01

### TO-257AA Package



Dimensions are typical [mm]

#### Caution

This package contains beryllia. Therefore it must not be in any form machined, grinded, sanded, polished or any other mechanical operation which will produce dust and particles.

#### Attention please!

The information given in this document shall in no event be regarded as a guarantee of conditions or characteristics ("Beschaffenheitsgarantie"). With respect to any examples or hints given herein, any typical values stated herein and/or any information regarding the application of the device, Infineon Technologies hereby disclaims any and all warranties and liabilities of any kind, including without limitation warranties of non-infringement of intellectual property rights of a third party.

#### Information

For further information on technology, delivery terms and conditions and prices please contact your nearest Infineon Technologies Office (<u>www.infineon.com</u>).

#### Warnings

Due to technical requirements components may contain dangerous substances. For information on the types in question please contact your nearest Infineon Technologies Office.

Infineon Technologies Components may only be used in life-support devices or systems with the expressed written approval of Infineon Technologies, if a failure of such components can reasonably be expected to cause the failure of that life-support device or system, or to affect the safety or effectiveness of that device or system.

Life support devices or systems are intended to be implanted in the human body, or to support and/or maintain and sustain and/or protect human life. If they fail, it is reasonable to assume that the health of the user or other persons may be endangered.